

**Notice of References Cited**

Application/Control No.

10/829,295

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,144,848 A	11-2000	Walsh et al.	455/419
*	B	US-6,233,565 B1	05-2001	Lewis et al.	705/35
*	C	US-2002/0040346 A1	04-2002	Kwan, Khai Hee	705/51
*	D	US-2002/0169623 A1	11-2002	Call et al.	705/1
*	E	US-2003/0002068 A1	01-2003	Constantin et al.	358/1.15
*	F	US-6,515,765 B1	02-2003	Umebayashi, Akito	358/1.9
*	G	US-2003/0047613 A1	03-2003	Funamoto et al.	235/462.01
*	H	US-6,545,767 B1	04-2003	Kuroyanagi, Satoshi	358/1.14
*	I	US-2003/0197887 A1	10-2003	Shenoy et al.	358/1.15
*	J	US-6,727,999 B1	04-2004	Takahashi, Hiroyuki	358/1.15
*	K	US-6,747,755 B1	06-2004	Satomi et al.	358/1.15
*	L	US-6,778,289 B1	08-2004	Iwata, Nobuo	358/1.15
*	M	US-2004/0169876 A1	09-2004	Takahashi, Hiroyuki	358/001.12

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/829,295

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,801,962 B2	10-2004	Taniguchi et al.	710/33
*	B	US-6,823,075 B2	11-2004	Perry, Burt W.	382/100
*	C	US-6,877,031 B2	04-2005	Watanabe et al.	709/217
*	D	US-6,934,048 B2	08-2005	Igarashi et al.	358/1.15
*	E	US-7,039,869 B2	05-2006	Smith, Milton	715/716
*	F	US-7,066,387 B2	06-2006	Itoh et al.	235/382
*	G	US-7,079,291 B2	07-2006	Ichikawa, Osamu	358/402
*	H	US-7,222,101 B2	05-2007	Bishop et al.	705/51
*	I	US-7,327,478 B2	02-2008	Matsuda, Hiroshi	358/1.14
*	J	US-7,502,133 B2	03-2009	Fukunaga et al.	358/1.15
*	K	US-7,611,049 B2	11-2009	Drummond et al.	235/379
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.